

<b>Notice of References Cited</b>	Application/Control No. 10/573,968		Applicant(s)/Patent Under Reexamination YOSHIMURA ET AL.	
	Examiner Hai C. Pham		Art Unit 2861	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0062179	04-2004	Tsurumi et al.	369/108
*	B	US-2003/0117932	06-2003	Morishima et al.	369/116
*	C	US-6,778,205	08-2004	Anderson et al.	347/251
*	D	US-5,473,154	12-1995	Eguchi et al.	250/201.5
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
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**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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**NON-PATENT DOCUMENTS**

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